

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/680,356	ISHII ET AL.	
Examiner	Art Unit	
	1622	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEARC)
·	DATE	EXMR
Double patenting, West, Palm inventors.	11/22/2008	IP